

IXTQ48N65X2M-VB Datasheet

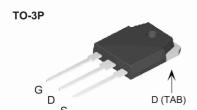
SJ_Multi-EPI 650V Single-N TO3P MOSFET

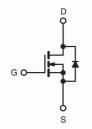
PRODUCT SUMMARY			
V _{DS} (V) at T _J max.	650		
R _{DS(on)} at 25 °C (Ω)	V _{GS} = 10 V	0.06	
Q _g max. (nC)	273		
Q _{gs} (nC)	46		
Q _{gd} (nC)	79		
Configuration	Single		

FEATURES

- Low figure-of-merit (FOM) Ron x Qg
- Low input capacitance (Ciss)
- Reduced switching and conduction losses
- Ultra low gate charge (Qq)
- Avalanche energy rated (UIS)







N-Channel MOSFET

APPLICATIONS

- Server and telecom power supplies
- Switch mode power supplies (SMPS)
- Power factor correction power supplies (PFC)
- Lighting
 - High-intensity discharge (HID)
 - Fluorescent ballast lighting
- Industrial
 - Welding
 - Induction heating
 - Motor drives
 - Battery chargers
 - Renewable energy
 - Solar (PV inverters)

ABSOLUTE MAXIMUM RATINGS (T _C = 25 °C, unless otherwise noted)						
PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			V_{DS}	650	V	
Gate-Source Voltage			V_{GS}	± 30		
Continuous Drain Current (T _J = 150 °C)	V _{GS} at 10 V	$T_C = 25 ^{\circ}C$ $T_C = 100 ^{\circ}C$	- I _D	47		
	VGS at 10 V	T _C = 100 °C		30	Α	
Pulsed Drain Current ^a			I _{DM}	142		
Linear Derating Factor				3.3	W/°C	
Single Pulse Avalanche Energy b			E _{AS}	1410	mJ	
Maximum Power Dissipation			P _D	415	W	
Operating Junction and Storage Temperature Range			T _J , T _{stg}	-55 to +150	°C	
Drain-Source Voltage Slope	T _J = 125 °C		dV/dt	37	V/ns	
Reverse Diode dV/dt d		dv/dt	9	V/IIS		
Soldering Recommendations (Peak Temperature) c	for 10 s			300	°C	

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature.
- b. $V_{DD} = 50$ V, starting $T_J = 25$ °C, L = 28.2 mH, $R_g = 25$ Ω , $I_{AS} = 10$ A.
- c. 1.6 mm from case.
- d. $I_{SD} \le I_D$, dI/dt = 100 A/µs, starting $T_J = 25$ °C.

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THERMAL RESISTANCE RATINGS					
PARAMETER	SYMBOL	MBOL TYP. MAX.		UNIT	
Maximum Junction-to-Ambient	R _{thJA}	-	40	°C/W	
Maximum Junction-to-Case (Drain)	R _{thJC}	-	0.3]	

PARAMETER	SYMBOL	TES	MIN.	TYP.	MAX.	UNIT	
Static		'					
Drain-Source Breakdown Voltage	V _{DS}	V _{GS} :	= 0 V, I _D = 250 μA	650	-	_	V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference	e to 25 °C, I _D = 1 mA	-	0.70	-	V/°C
Gate-Source Threshold Voltage (N)	V _{GS(th)}	V _{DS} =	= V _{GS} , I _D = 250 μA	2	-	4	V
0.10	I _{GSS}	V _{GS} = ± 20 V		-	-	± 100	nA
Gate-Source Leakage			V _{GS} = ± 30 V		-	± 1	μΑ
7 0 1 1/1 5 1 0 1		V _{DS} =	V _{DS} = 650 V, V _{GS} = 0 V V _{DS} = 520 V, V _{GS} = 0 V, T _J = 125 °C		-	1	μА
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 520 V			-	25	
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = 10 V	I _D = 24 A	-	0.06	-	Ω
Forward Transconductance	9 _{fs}	V _{DS} = 30 V, I _D = 24 A		-	16.7	-	S
Dynamic							
Input Capacitance	C _{iss}	V _{GS} = 0 V, V _{DS} = 100 V, f = 1 MHz		-	5682	-	pF
Output Capacitance	C _{oss}			-	251	-	
Reverse Transfer Capacitance	C _{rss}			-	1	-	
Effective Output Capacitance, Energy Related ^a	C _{o(er)}	V _{DS} = 0 V to 520 V, V _{GS} = 0 V		-	192	-	
Effective Output Capacitance, Time Related ^b	C _{o(tr)}			-	665	-	
Total Gate Charge	Q_g		V _{GS} = 10 V I _D = 24 A, V _{DS} = 520 V	-	182	273	nC
Gate-Source Charge	Q _{gs}	V _{GS} = 10 V		-	46	-	
Gate-Drain Charge	Q _{gd}		!		79	-	1
Turn-On Delay Time	t _{d(on)}			-	47	94	ns
Rise Time	t _r	V _{DD}	$V_{DD} = 520 \text{ V, } I_D = 6 \text{ A,}$ $V_{GS} = 10 \text{ V, } R_g = 9.1 \Omega$		87	131	
Turn-Off Delay Time	t _{d(off)}	V _{GS} =			156	234	
Fall Time	t _f	1		-	103	206	
Gate Input Resistance	R _g	f = 1 MHz, open drain		-	0.64	-	Ω
Drain-Source Body Diode Characteristic	s						
Continuous Source-Drain Diode Current	I _S	MOSFET symbol showing the integral reverse p - n junction diode		-	-	47	
Pulsed Diode Forward Current	I _{SM}			_	-	139	A
Diode Forward Voltage	V _{SD}	T _J = 25 °C, I _S = 24 A, V _{GS} = 0 V		-	0.9	1.2	V
Reverse Recovery Time	t _{rr}	T _J = 25 °C, I _F = I _S = 24 A, dl/dt = 100 A/µs, V _R = 25 V		-	753	1506	ns
Reverse Recovery Charge	Q _{rr}			-	14	28	μC
Reverse Recovery Current	I _{RRM}			_	28	_	'A

- a. $C_{oss(er)}$ is a fixed capacitance that gives the same energy as C_{oss} while V_{DS} is rising from 0 % to 80 % V_{DSS} . b. $C_{oss(tr)}$ is a fixed capacitance that gives the same charging time as C_{oss} while V_{DS} is rising from 0 % to 80 % V_{DSS} .

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TYPCIAL CHARACTERISTICS (25 °C, unless otherwise noted)

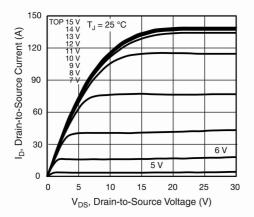


Fig. 1 - Typical Output Characteristics

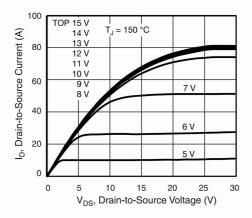


Fig. 2 - Typical Output Characteristics

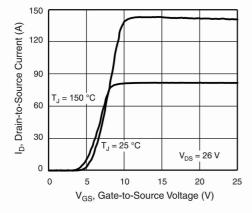


Fig. 3 - Typical Transfer Characteristics

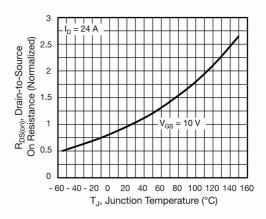


Fig. 4 - Normalized On-Resistance vs. Temperature

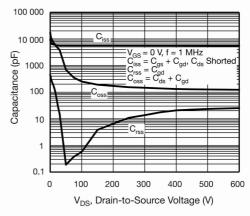


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

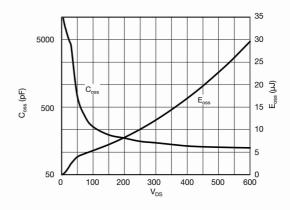


Fig. 6 - C_{oss} and E_{oss} vs. V_{DS}



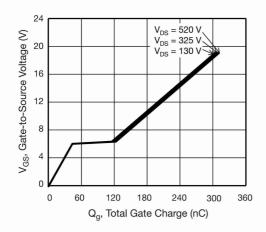


Fig. 7 - Typical Gate Charge vs. Gate-to-Source Voltage

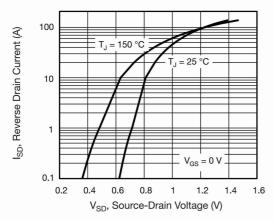


Fig. 8 - Typical Source-Drain Diode Forward Voltage

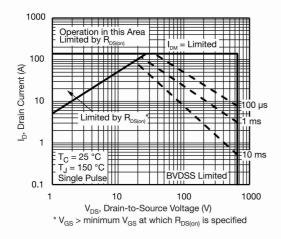


Fig. 9 - Maximum Safe Operating Area

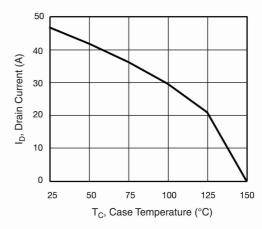


Fig. 10 - Maximum Drain Current vs. Case Temperature

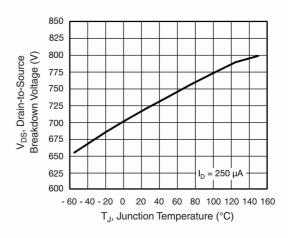


Fig. 11 - Temperature vs. Drain-to-Source Voltage

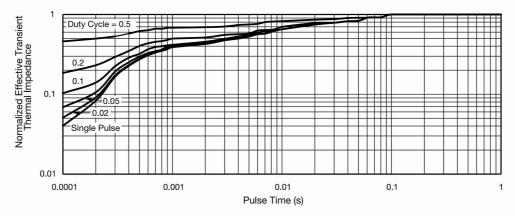


Fig. 12 - Normalized Thermal Transient Impedance, Junction-to-Case

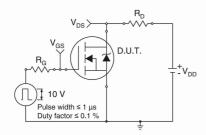


Fig. 13 - Switching Time Test Circuit

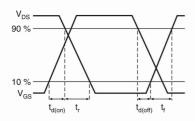


Fig. 14 - Switching Time Waveforms

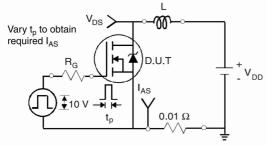


Fig. 15 - Unclamped Inductive Test Circuit

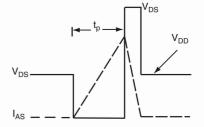


Fig. 16 - Unclamped Inductive Waveforms

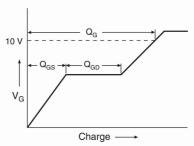


Fig. 17 - Basic Gate Charge Waveform

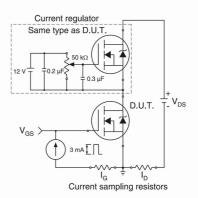


Fig. 18 - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit Circuit layout considerations Low stray inductance Ground plane Low leakage inductance current transformer d d d d d d Low leakage inductance current transformer odv/dt controlled by Rg Driver same type as D.U.T. I_{SD} controlled by duty factor "D" D.U.T. - device under test

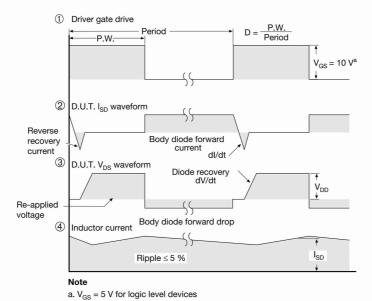


Fig. 19 - For N-Channel



TO-3P 15.60 ± 0.20 4.80 ± 0.20 13.60 ± 0.20 3.80 ± 0.20 1.50 ^{+0.15} -0.05 $\emptyset 3.20 \pm 0.10$ 9.60 ± 0.20 12.76 ± 0.20 19.90 ±0.20 23.40 ±0.20 13.90 ±0.20 2.00 ± 0.20 3.50 ±0.20 3.00 ± 0.20 16.50 ± 0.30 1.40 ± 0.20 1.00 ± 0.20 $0.60^{\,+0.15}_{\,-0.05}$ 5.45TYP 5.45TYP [5.45 ±0.30] [5.45 ±0.30]



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